

## DESCRIPTION

The MXN65N04 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

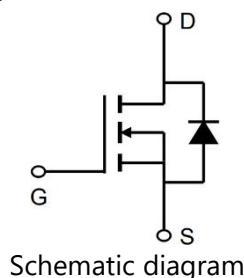
## GENERAL FEATURES

- $V_{DS}=40V$ ,  $I_D=65A$
- $R_{DS(ON)}(\text{Typ.})=10m\Omega$  @  $V_{GS}=4.5V$
- $R_{DS(ON)}(\text{Typ.})=8.0m\Omega$  @  $V_{GS}=10V$

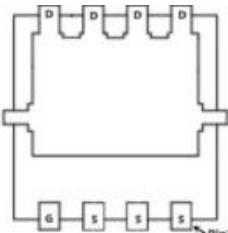
## APPLICATION

- Battery protection
- Load switch
- Uninterruptible power supply

## PINOUT



Marking and pin Assignment



DFN5\*3-3 top & bottom view

## ORDERING INFORMATION

Part Number	Storage Temperature	Package	Devices Per Reel
MXN65N04	-55°C to 150°C	DFN3*3-8L	5000

## ABSOLUTE MAXIMUM RATINGS( $T_c=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	40	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current-Continuous( $V_{GS}=10V$ , $T_c=25^\circ C$ ) <sup>(Note1)</sup>	$I_D$	65	A
Drain Current-Continuous( $V_{GS}=10V$ , $T_c=100^\circ C$ ) <sup>(Note1)</sup>	$I_D$	28	A
Pulsed Drain Current <sup>(Note2)</sup>	$I_{DM}$	180	A
Single Pulse Avalanche Energy <sup>(Note3)</sup>	$E_{AS}$	81	mJ
Avalanche Current	$I_{AS}$	10	A
Power Dissipation <sup>(Note4)</sup>	$P_D$	27.8	W
Operating Junction and Storage Temperature Range	$T_J$ , $T_{STG}$	-55 to 150	°C
Thermal Resistance, Junction-to-Ambient <sup>(Note1)</sup>	$R_{\theta JA}$	60	°C/W
Thermal Resistance, Junction-to-Case <sup>(Note1)</sup>	$R_{\theta JC}$	4.5	°C/W

Note1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

Note2. The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$

Note3. The  $E_{AS}$  data shows Max. rating . The test condition is  $V_{DD}=36V$ ,  $V_{GS}=10V$ ,  $L=0.1mH$ ,  $I_{AS}=10A$

Note4. The power dissipation is limited by 150°C junction temperature


**ELECTRICAL CHARACTERISTICS**( $T_J=25^\circ\text{C}$  unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
-----------	--------	------------	-----	-----	-----	------

**Off Characteristics**

Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	40	-	-	V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}}=40\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	$\mu\text{A}$
		$V_{\text{DS}}=40\text{V}, V_{\text{GS}}=0\text{V}, T_J=55^\circ\text{C}$	-	-	5	
Gate-Body Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	$\pm 100$	nA

**On Characteristics**

Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.2	1.6	2.5	V
Drain-Source On-State Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=15\text{A}$	-	10	13	$\text{m}\Omega$
		$V_{\text{GS}}=10\text{V}, I_{\text{D}}=30\text{A}$	-	8.0	10	$\text{m}\Omega$
Forward Transconductance	$g_{\text{fs}}$	$V_{\text{DS}}=5\text{V}, I_{\text{D}}=30\text{A}$	-	22	-	S

**Dynamic Characteristics**

Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=20\text{V}, V_{\text{GS}}=0\text{V}, F=1.0\text{MHz}$	-	2400	-	pF
Output Capacitance	$C_{\text{oss}}$		-	192	-	pF
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	165	-	pF
Gate Resistance	$R_g$	$V_{\text{DS}}=0\text{V}, V_{\text{GS}}=0\text{V}, F=1.0\text{MHz}$	-	1.7	3.4	$\Omega$

**Switching Characteristics**

Turn-on Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=30\text{V}, I_{\text{D}}=25\text{A}, V_{\text{GS}}=10\text{V}, R_{\text{G}}=1\Omega$	-	12	-	nS
Turn-on Rise Time	$t_r$		-	12	-	nS
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	38	-	nS
Turn-Off Fall Time	$t_f$		-	9	-	nS
Total Gate Charge	$Q_g$	$V_{\text{DS}}=20\text{V}, I_{\text{D}}=25\text{A}, V_{\text{GS}}=10\text{V}$	-	37	-	nC
Gate-Source Charge	$Q_{\text{gs}}$		-	6	-	nC
Gate-Drain Charge	$Q_{\text{gd}}$		-	7	-	nC

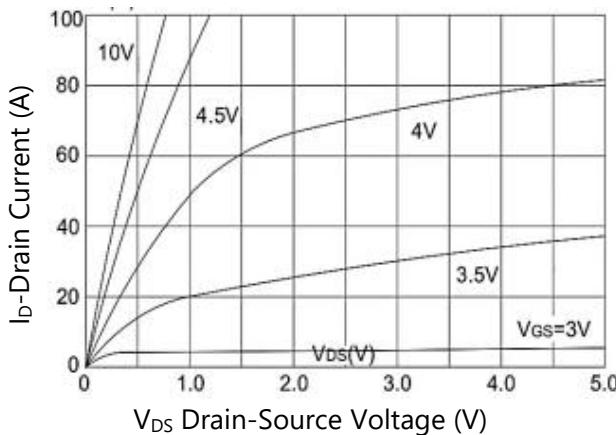
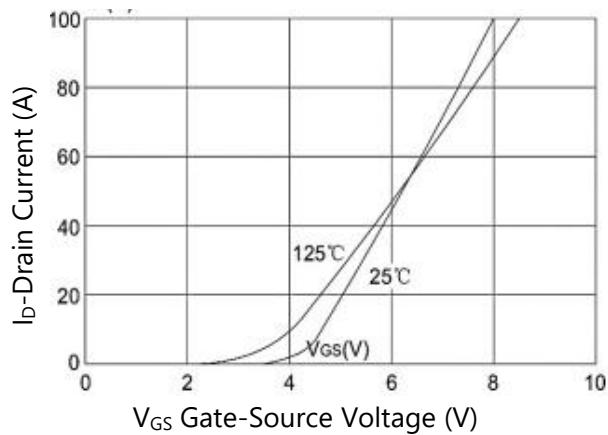
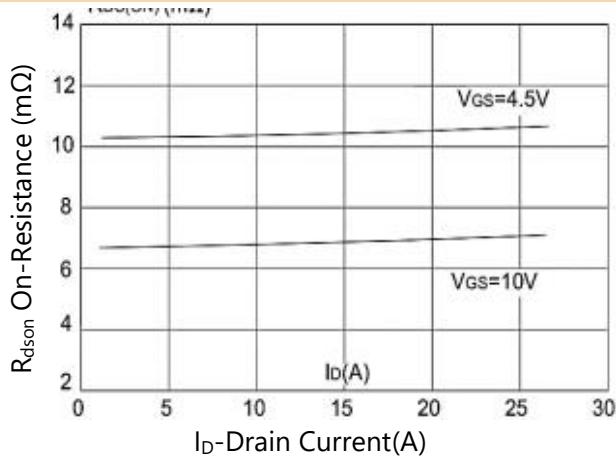
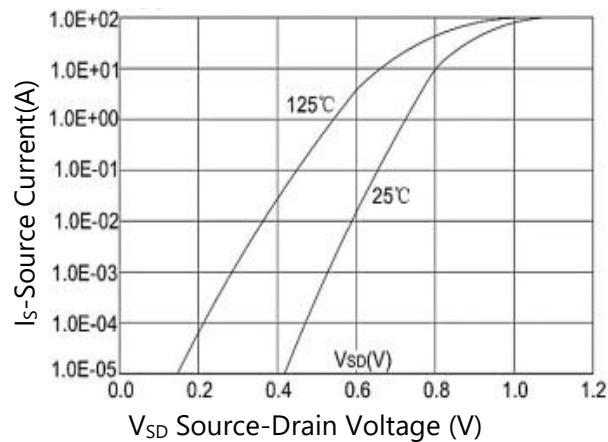
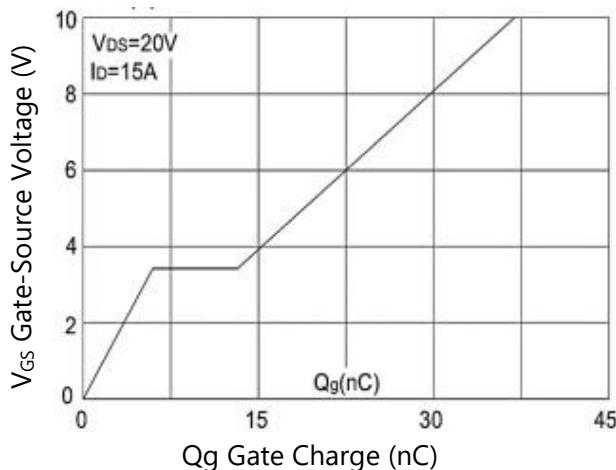
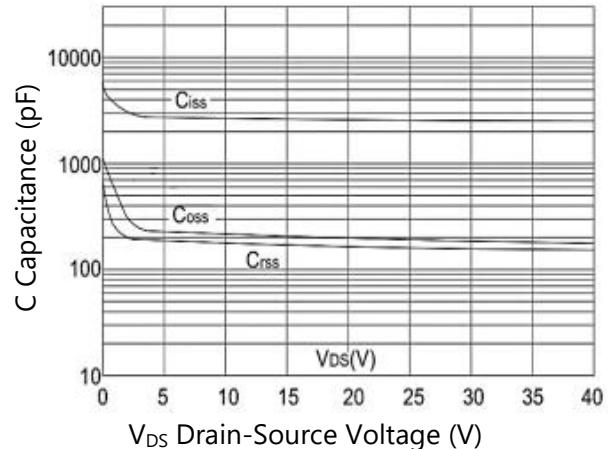
**Drain-Source Diode Characteristics**

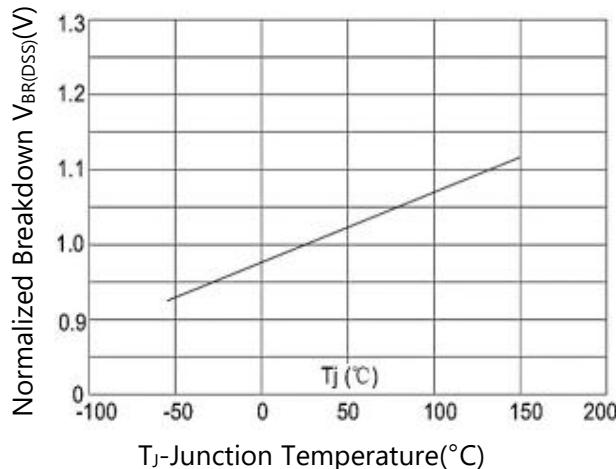
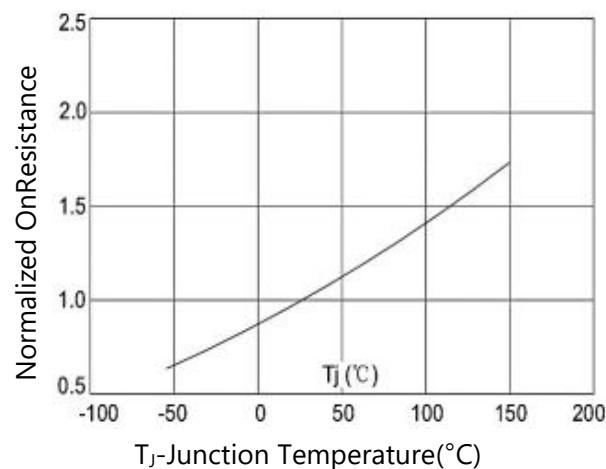
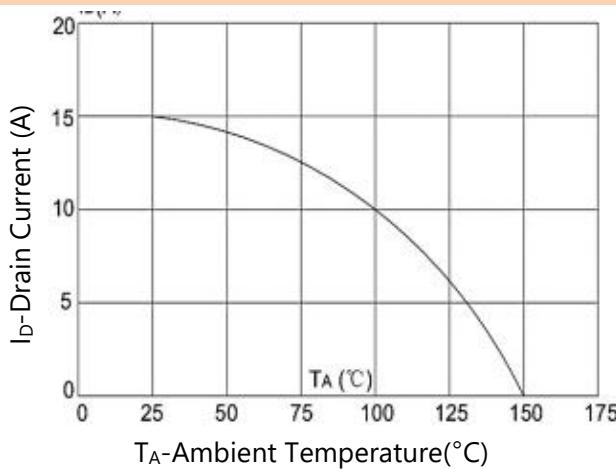
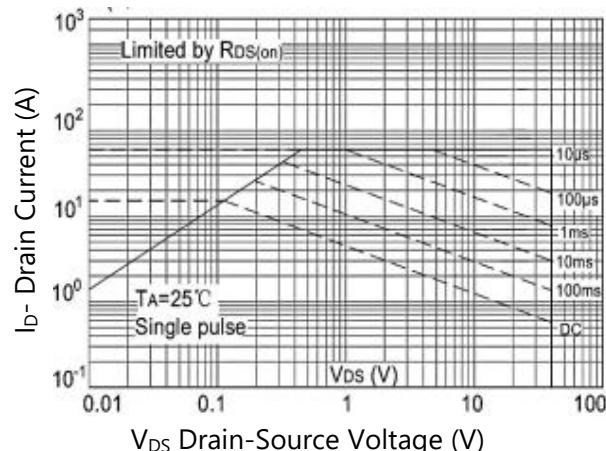
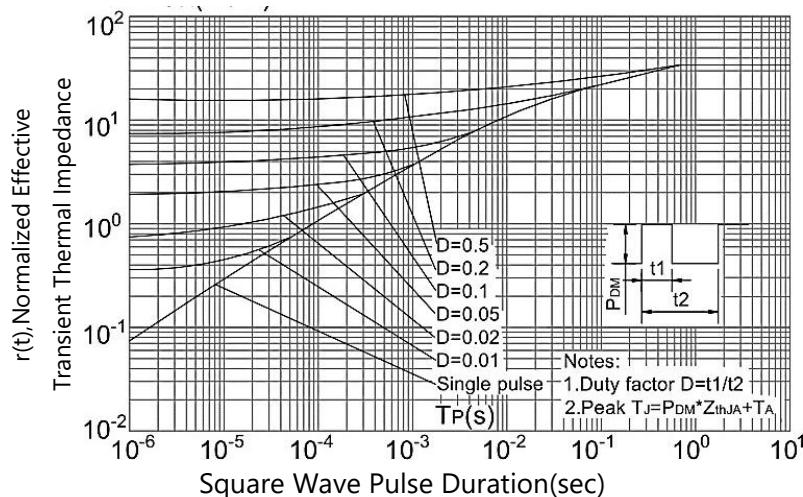
Continuous Source Current <sup>(Note1)(Note5)</sup>	$I_s$	$V_G=V_D=0\text{V}, \text{Force Current}$	-	-	50	A
Pulsed Source Current <sup>(Note2)(Note5)</sup>	$I_{\text{SM}}$		-	-	200	A
Diode Forward Voltage <sup>(Note2)</sup>	$V_{\text{SD}}$	$V_{\text{GS}}=0\text{V}, I_s=1\text{A}$	-	-	1.2	V
Reverse Recovery Time	$t_{\text{rr}}$	$I_F=30\text{A}, dI/dt=100\text{A}/\mu\text{s}$	-	22	-	nS
Reverse Recovery Charge	$Q_{\text{rr}}$		-	11	-	nC

Note1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

Note2.The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$

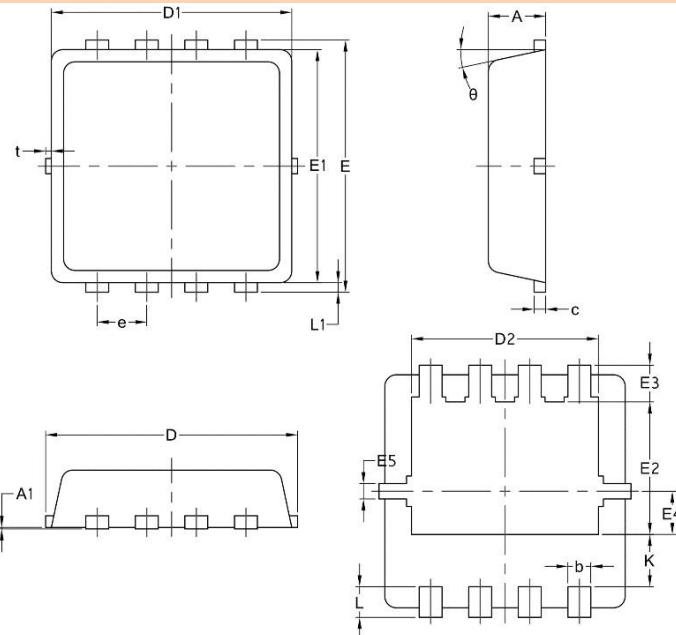
Note5.The data is theoretically the same as  $I_D$  and  $I_{\text{DM}}$  , in real applications , should be limited by total power dissipation


**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**
**Figure 1. Output Characteristics**

**Figure 2. Transfer Characteristics**

**Figure 3. On-Resistance vs Drain Current**

**Figure 4. Body Diode Characteristics**

**Figure 5. Gate Charge**

**Figure 6. Capacitance vs VDS**



**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**
**Figure 7.  $V_{BR(DSS)}$  vs Junction Temperature**

**Figure 8.  $R_{DS(on)}$  vs Junction Temperature**

**Figure 9. Drain Current vs Ambient Temperature**

**Figure 10. Safe Operation Area**

**Figure 11. Normalized Maximum Transient Thermal Impedance**


## PACKAGE INFORMATION

### DFN3\*3-8L



Symbol	Dimensions In Millimeters		
	Min.	Max.	Min.
A	0.70	0.75	0.85
A1	-	-	0.05
b	0.20	0.30	0.40
c	0.10	0.152	0.25
D	3.15	3.30	3.45
D1	3.00	3.15	3.25
D2	2.29	2.45	2.65
E	3.15	3.30	3.45
E1	2.90	3.05	3.20
E2	1.54	1.74	1.94
E3	0.28	0.48	0.65
E4	0.37	0.57	0.77
E5	0.10	0.20	0.30
e	0.60	0.65	0.70
K	0.59	0.69	0.89
L	0.30	0.40	0.50
L1	0.06	0.125	0.20
t	0	0.075	0.13
Φ	10	12	14